Search Notes			
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Application/Control No.	Applicant(s)/Patent under Reexamination	·
09/965,588	LUIJTEN ET AL.	
Examiner	Art Unit	
Andrew Lee	2616	

SEARCHED				
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
Inventors and interference search See East Search	6/9/2006	AL